Power MOSFET

30 V, 66 A, Single N-Channel, SO-8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- These are Pb-Free Devices*

Applications

- CPU Power Delivery
- DC-DC Converters
- High Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage		V_{DSS}	30	V	
Gate-to-Source Voltage		V_{GS}	±20	V	
Continuous Drain Current R _{0JA} (Note 1)		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι _D	15 10.8	Α
Power Dissipation R _{0JA} (Note 1)		T _A = 25°C	P _D	2.16	W
Continuous Drain Current $R_{\theta JA} \leq$ 10 sec		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι _D	24.3 17.5	Α
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T _A = 25°C	P _D	5.67	W
Continuous Drain	State	T _A = 25°C	I _D	9.5	Α
Current R _{0JA} (Note 2)		T _A = 85°C		6.9	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.87	W
Continuous Drain		T _C = 25°C	I _D	66	Α
Current R _{θJC} (Note 1)		T _C = 85°C		47.8	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	41.7	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	132	Α
Current limited by pa	ckage	T _A = 25°C	I _{Dmaxpkg}	100	Α
Operating Junction and Storage Temperature		T _J , T _{STG}	-40 to +150	°C	
Source Current (Body Diode)		I _S	41.7	Α	
Drain to Source dV/dt		dV/dt	6	V/ns	
Single Pulse Drain–to–Source Avalanche Energy (V_{DD} = 50 V, V_{GS} = 10 V, I_{L} = 27 A_{pk} , L = 0.3 mH, R_{G} = 25 Ω)		EAS	109	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

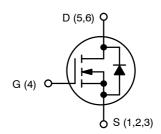
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



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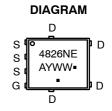
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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	5.9 mΩ @ 10 V	66 A
30 V	8.7 mΩ @ 4.5 V	55 A



N-CHANNEL MOSFET





MARKING

A = Assembly Location

Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]		
NTMFS4826NET1G	SO-8FL (Pb-Free)	1500 / Tape & Reel		
NTMFS4826NET3G	SO-8FL (Pb-Free)	5000 / Tape & Reel		

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.0	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	57.8	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	143.5	°C/W
Junction-to-Ambient - t ≤ 10 sec	$R_{\theta JA}$	22.1	
Junction-to-Top	$R_{ heta JT}$	9.7	

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					_	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25 ^{\circ}\text{C}$				1	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 16 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.45	1.8	2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V to	I _D = 30 A		4.3	5.9	_
		11.5 V	I _D = 15 A		4.2		
		V _{GS} = 4.5 V	I _D = 30 A		6.6	8.7	mΩ
			I _D = 15 A		6.5		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 30 A			62		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				1850		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 12 V			333		pF
Reverse Transfer Capacitance	C _{RSS}				170		
Total Gate Charge	Q _{G(TOT)}				13.5	20	
Threshold Gate Charge	Q _{G(TH)}	V 45VV	15 \\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		1.7]
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			5.1		nC
Gate-to-Drain Charge	Q_{GD}				4.5		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 11.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 30 \text{ A}$			32		nC
SWITCHING CHARACTERISTICS (Note 4)						•	•
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_{D} = 15 \text{ A},$ $R_{G} = 3.0 \Omega$			14.4		
Rise Time	t _r				39.8		1
Turn-Off Delay Time	t _{d(OFF)}				18.6		ns
Fall Time	t _f				5.2		1

- 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
- 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)			-	-		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 11.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			9.5		ns
Rise Time	t _r				22		
Turn-Off Delay Time	t _{d(OFF)}				25		
Fall Time	t _f				4.6		
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						
Forward Diode Voltage	V _{SD}	V_{SD} $V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$		0.84	1.0	V	
			T _J = 125°C		0.73		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			13.2		ns
Charge Time	ta				8.5		
Discharge Time	t _b				4.7		
Reverse Recovery Charge	Q _{RR}				3.5		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S	T _A = 25°C			0.93		nΗ
Drain Inductance	L _D				0.005		1
Gate Inductance	L _G				1.84		
Gate Resistance	R_{G}				0.9		Ω

^{3.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

TYPICAL CHARACTERISTICS

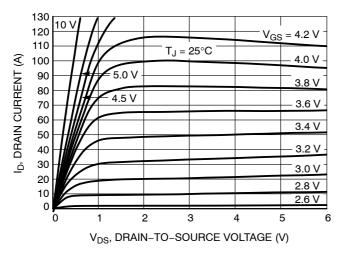


Figure 1. On-Region Characteristics

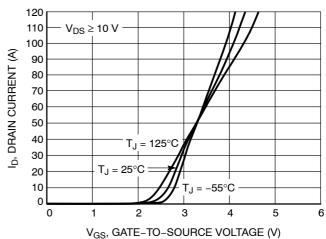


Figure 2. Transfer Characteristics

^{4.} Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

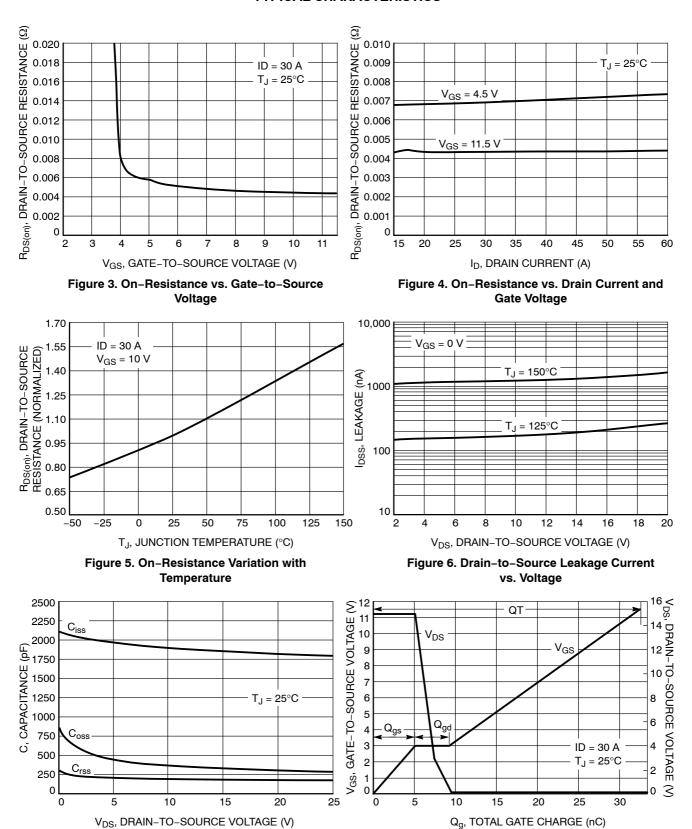


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and

Drain-to-Source Voltage vs. Total Charge

TYPICAL CHARACTERISTICS

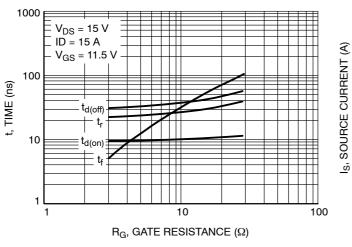


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

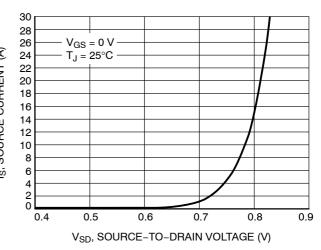


Figure 10. Diode Forward Voltage vs. Current

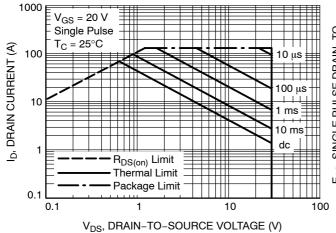


Figure 11. Maximum Rated Forward Biased Safe Operating Area

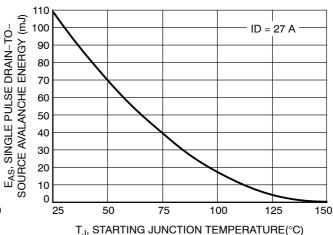


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

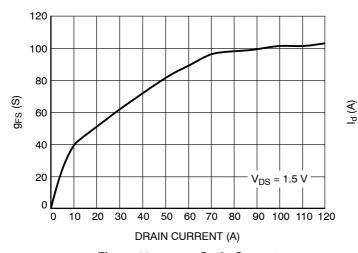


Figure 13. g_{FS} vs. Drain Current

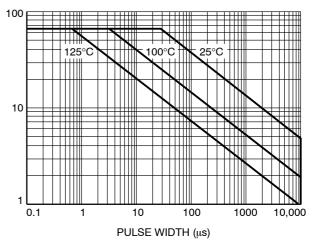
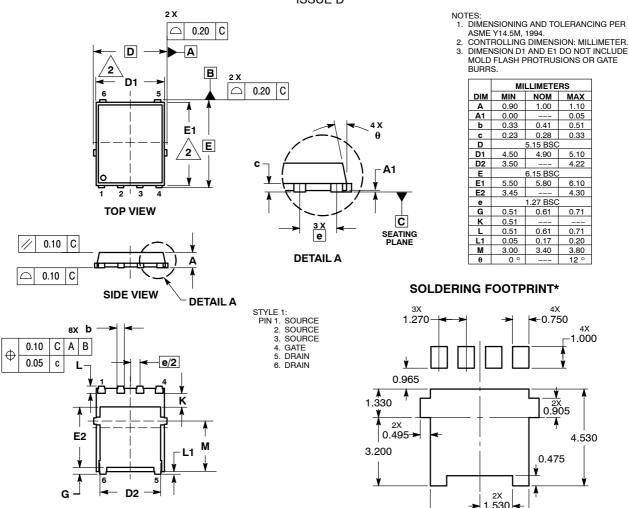


Figure 14. Avalanche Characteristics

PACKAGE DIMENSIONS

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA-01 ISSUE D



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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